

Application No.	Applicant(s)
10/083,904	SZTYKIEL ET AL.
Examiner	Art Unit
Hau V Phan	3618

SEARCHED				
Class	Subclass	Date	Examiner	
180	68.3, 291	4/8/2004	HP	
	58, 68.1			
	68.2, 292			
	299			
280	781	4/8/2004	HP	
-	789			
	796			
	790			
	796			
296	164	4/8/2004	HP	
	178			
	204			
	205			

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
180	290-300	4/8/2004	НР	
280	781-800	4/8/2004	HP	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
	DATE	EXMR	
		<u> </u>	
	ii		